

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10058173	STEFANIK ET AL.
	Examiner	Art Unit
	Zhen, Li B	2194

SEARCHED

Class	Subclass	Date	Examiner
717	171,172,173,177	6/27/2007	LZ
update	search	12/4/07	LZ
update	search	6/10/2008	LZ
update	search	11/26/2008	LZ
update	search	5/15/2009	LZ
update	search	6/18/2010	LZ

SEARCH NOTES

Search Notes	Date	Examiner
EAST (US-PGPUB;USPAT;USOCR;EPO;DERWENT;IBMTDB) See search history printout	6/27/2007	LZ
Inventor Name Search	6/27/2007	LZ
EAST (US-PGPUB;USPAT;USOCR;EPO;DERWENT;IBMTDB) See search history printout	12/4/07	LZ
EAST (US-PGPUB;USPAT;USOCR;EPO;DERWENT;IBMTDB) See search history printout	6/10/2008	LZ
EAST (US-PGPUB;USPAT;USOCR;EPO;DERWENT;IBMTDB) See search history printout	11/26/2008	LZ
EAST (US-PGPUB;USPAT;USOCR;EPO;DERWENT;IBMTDB) See search history printout	5/15/2009	LZ
EAST (US-PGPUB;USPAT;USOCR;EPO;DERWENT;IBMTDB) See search history printout	6/18/2010	LZ

INTERFERENCE SEARCH

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